

Absolute Maximum Ratings		Values	Units
Symbol	Conditions ¹⁾		
V _{CES}		600	V
V _{CGR}	R _{GE} = 20 kΩ	600	V
I _C	T _{case} = 25/75 °C	70 / 50	A
I _{CM}	T _{case} = 25/75 °C; t _p = 1 ms	140 / 100	A
V _{GES}		± 20	V
P _{tot}	per IGBT, T _{case} = 25 °C	250	W
T _J , (T _{stg})		-40 ... +150 (125)	°C
V _{isol}	AC, 1 min.	2500	V
humidity	DIN 40040	Class F	
climate	DIN IEC 68 T.1	40/125/56	
Inverse Diode			
I _F = -I _C	T _{case} = 25/80 °C	75 / 50	A
I _{FM} = -I _{CM}	T _{case} = 25/80 °C; t _p = 1 ms	140 / 100	A
I _{FSM}	t _p = 10 ms; sin.; T _J = 150 °C	440	A
I ² t	t _p = 10 ms; T _J = 150 °C	970	A ² s

Characteristics		min.	typ.	max.	Units
Symbol	Conditions ¹⁾				
V _{(BR)CES}	V _{GE} = 0, I _C = 1,5 mA	≥ V _{CES}	–	–	V
V _{GE(th)}	V _{GE} = V _{CE} , I _C = 1 mA	4,5	5,5	6,5	V
I _{CES}	V _{GE} = 0 } T _J = 25 °C	–	0,1	1,5	mA
	V _{CE} = V _{CES} } T _J = 125 °C	–	3	–	mA
I _{GES}	V _{GE} = 20 V, V _{CE} = 0	–	–	100	nA
V _{CEsat}	I _C = 30 A } V _{GE} = 15 V;	–	1,8(2,0)	–	V
V _{CEsat}	I _C = 50 A } T _J = 25 (125) °C }	–	2,1(2,4)	2,5(2,8)	V
g _{fs}	V _{CE} = 20 V, I _C = 50 A	20	–	–	S
C _{CHC}	per IGBT	–	–	350	pF
C _{ies}	V _{GE} = 0	–	2800	–	pF
C _{oes}	V _{CE} = 25 V	–	300	–	pF
C _{res}	f = 1 MHz	–	200	–	pF
L _{CE}		–	–	60	nH
t _{d(on)}	V _{CC} = 300 V	–	50	–	ns
t _r	V _{GE} = -15 V / +15 V ³⁾	–	40	–	ns
t _{d(off)}	I _C = 50 A, ind. load	–	300	–	ns
t _f	R _{Gon} = R _{Goff} = 22 Ω	–	30	–	ns
E _{on}	T _J = 125 °C	–	2,5	–	mWs
E _{off}		–	1,8	–	mWs
Inverse Diode ⁸⁾					
V _F = V _{EC}	I _F = 50 A } V _{GE} = 0 V;	–	1,45(1,35)	1,7	V
	T _J = 25 (125 °C) }				
V _{TO}	T _J = 125 °C	–	–	0,9	V
r _t	T _J = 125 °C	–	10	15	mΩ
I _{RRM}	I _F = 50 A; T _J = 125 °C ²⁾	–	31	–	A
Q _{rr}	I _F = 50 A; T _J = 125 °C ²⁾	–	3,2	–	μC
Thermal characteristics					
R _{thjc}	per IGBT	–	–	0,5	°C/W
R _{thjc}	per diode	–	–	1,0	°C/W
R _{thch}	per module	–	–	0,05	°C/W

Diagrams Fig. 1 to 24 of type SKM 50GB063D apply

***) 7-pack = three phase inverter plus brake chopper

****) 4-pack, branch W left off

¹⁾ T_{case} = 25 °C, unless otherwise specified

²⁾ I_F = -I_C, V_R = 300 V, -di_F/dt = 800 A/μs, V_{GE} = 0 V

³⁾ Use V_{GEoff} = -5... -15 V

⁸⁾ CAL = Controlled Axial Lifetime Technology

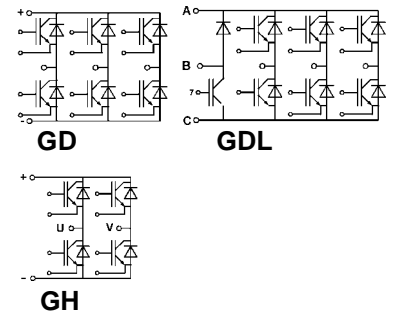
⁹⁾ Compared to PT-IGBT

SEMITRANS® Superfast NPT-IGBT Modules

SKM 50 GD 063 DL
SKM 50 GDL 063 D)**
SKM 50 GH 063 DL *)**



SIXPACK / 7-Pack)/ 4-Pack***)**



Features

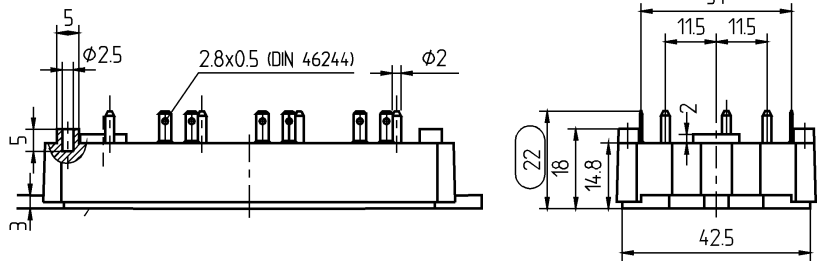
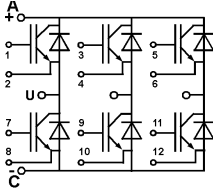
- N channel, homogeneous Silicon structure (NPT- Non punch-through IGBT)
 - Low tail current with low temperature dependence
 - High short circuit capability, self limiting if term. G is clamped to E
 - Pos. temp.-coeff. of V_{CEsat}
 - 50 % less turn off losses ⁹⁾
 - 30 % less short circuit current ⁹⁾
 - Very low C_{ies}, C_{oes}, C_{res} ⁹⁾
 - Latch-up free
 - Fast & soft inverse CAL diodes ⁸⁾
 - Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
 - Large clearance (9 mm) and creepage distances (13 mm)
- ### Typical Applications
- Switching (not for linear use)
 - Switched mode power supplies
 - UPS
 - Three phase inverters for servo / AC motor speed control
 - Pulse frequencies also > 10 kHz

Cases and mech. data → B 6 – 14

SEMITRANS® Sixpack

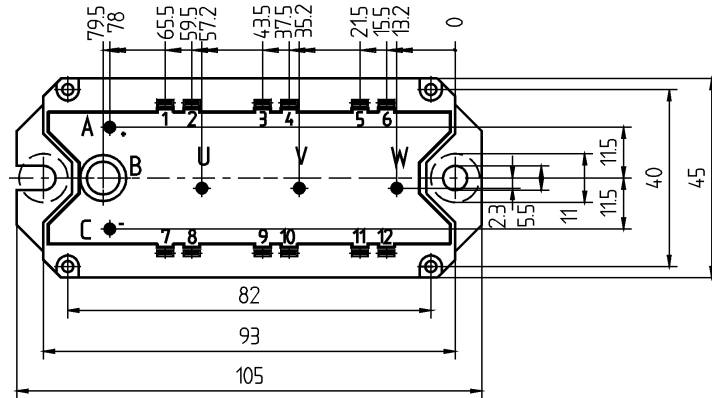
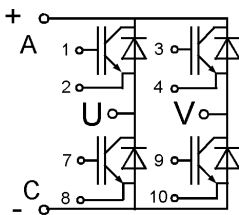
Case D 68
 UL Recognized
 File no. E 63 532
SKM 50 GD 063 DL

CASED68



SKM 50 GH 063 DL

Case D77 (= D68 without terminal W)



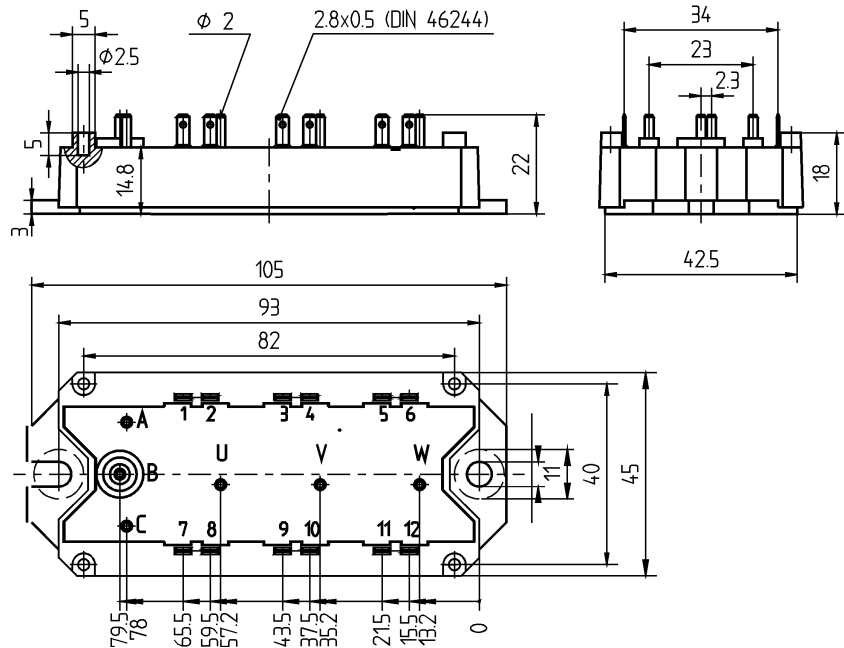
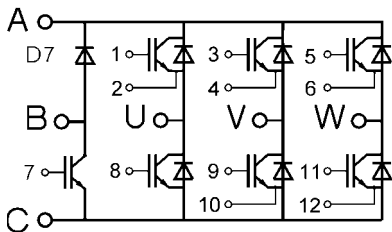
SEMITRANS® Sevenpack

Case D 73
 UL Recognized
 File no. E 63 532

CASED73

SKM 50 GDL 063 D

GCIGGDL



Dimensions in mm

Case outlines and circuit diagrams

Mechanical Data		Values			Units
Symbol	Conditions	min.	typ.	max.	
M ₁	to heatsink, SI Units (M5) to heatsink, US Units	4	—	5	Nm lb.in.
a		—	—	5x9,81	m/s ²
w		—	—	175	g

This is an electrostatic discharge sensitive device (ESDS). Please observe the international standard IEC 747-1, Chapter IX.

Two devices are supplied in one SEMIBOX A.

Larger packing units (10 or 20 pieces) are used if suitable SEMIBOX → page C - 1.